Interview process at the Department of Electronic Systems Engineering (DESE) for admission to MTech programmes in Electronic Product Design (EPD) Electronic Systems Engineering (ESE), and Microelectronic and VLSI Design (MVLSI)

The selection to the MTech programmes in the Department of Electronic Systems Engineering (DESE) is based on performance in GATE and an admission test/interview conducted by the department. As per the MoE guidelines, a minimum of 70% weightage will be given to the performance in GATE and the remaining will be for performance in test/interview. A minimum passing mark of 40% in the test/interview is essential for qualifying for admission.

The interview process comprises of two parts

- 1. e-Viva: The candidate will have to undertake an e-Viva for 30 minutes. The questions will test candidates' aptitude to apply and synthesize. This will be an online test conducted within the department and it will be proctored.
- 2. Committee interview: The e-Viva will be followed by an in-person interview by a team of faculty to evaluate the candidate on technical and interpersonal skills. This may last from 15 minutes to 30 minutes.

The questions in the e-Viva will be of three types:

- 1. MCQ: Multiple Choice Questions where the candidate will choose the correct answer from a set of possible solutions.
- 2. MSQ: Multiple Select Questions where the candidate needs to choose all the correct answers from a set of possible solutions. This type of questions will have multiple answers which are correct. The grading will be accordingly weighted.
- 3. CQ: Calculated Questions where the candidate needs to work out the answer to the question based on the values provided and enter the answer in the text box provided.

All the technical questions in the e-Viva and committee interview will be related to the representative syllabus given in the Annexure.

ANNEXURE

Syllabus for MTech Admissions (ESE, EPD, MVLSI)

Engineering Mathematics

Linear Algebra: Vector space, basis, linear dependence and independence, matrix algebra, eigenvalues and eigenvectors, rank, solution of linear equations- existence and uniqueness.

Calculus: Mean value theorems, theorems of integral calculus, evaluation of definite and improper integrals, partial derivatives, maxima and minima, multiple integrals, line, surface and volume integrals, Taylor series.

Differential Equations: First order equations (linear and nonlinear), higher order linear differential equations, Cauchy's and Euler's equations, methods of solution using variation of parameters, complementary function and particular integral, partial differential equations, variable separable method, initial and boundary value problems.

Vector Analysis: Vectors in plane and space, vector operations, gradient, divergence and curl, Gauss's, Green's and Stokes' theorems.

Complex Analysis: Analytic functions, Cauchy's integral theorem, Cauchy's integral formula, sequences, series, convergence tests, Taylor and Laurent series, residue theorem.

Probability and Statistics: Mean, median, mode, standard deviation, combinatorial probability, probability distributions, binomial distribution, Poisson distribution, exponential distribution, normal distribution, joint and conditional probability.

Networks, Signals and Systems

Circuit analysis: Node and mesh analysis, superposition, Thevenin's theorem, Norton's theorem, reciprocity. Sinusoidal steady state analysis: phasors, complex power, maximum power transfer. Representation of continuous and discrete time signals, shifting and scaling properties, linear time invariant and causal systems, Fourier series representation of continuous and discrete time periodic signals, sampling theorem, Applications of Fourier Transform for continuous and discrete time signals, Laplace Transform and Z transform. R.M.S. value, average value calculation for any general periodic waveform.

Time and frequency domain analysis of linear circuits: RL, RC and RLC circuits, solution of network equations using Laplace transform. Linear 2-port network parameters, wye-delta transformation. Continuous-time signals: Fourier series and Fourier transform, sampling theorem and applications.

Discrete-time signals: DTFT, DFT, z-transform, discrete-time processing of continuous-time signals.

LTI systems: definition and properties, causality, stability, impulse response, convolution, poles and zeroes, frequency response, group delay, phase delay.

Electronic Devices

Energy bands in intrinsic and extrinsic semiconductors, equilibrium carrier concentration, direct and indirect band-gap semiconductors.

 $Carrier\ transport:$ diffusion current, drift current, mobility and resistivity, generation and

recombination of carriers, Poisson, and continuity equations.

P-N junction, Zener diode, BJT, MOS capacitor, MOSFET, LED, photo diode and solar cell.

Analog Circuits

Diode circuits: clipping, clamping and rectifiers.

BJT and MOSFET amplifiers: biasing, AC coupling, small signal analysis, frequency response. Current mirrors and differential amplifiers.

Op-amp circuits: Amplifiers, summers, differentiators, integrators, active filters, Schmitt triggers and oscillators.

Digital Circuits

Number representations: binary, integer and floating-point- numbers.

Combinatorial circuits: Boolean algebra, minimization of functions using Boolean identities and Karnaugh map, logic gates and their static CMOS implementations, arithmetic circuits, code converters, multiplexers, decoders.

Sequential circuits: latches and flip-flops, counters, shift-registers, finite state machines, propagation delay, setup and hold time, critical path delay.

Data converters: sample and hold circuits, ADCs, and DACs.

Semiconductor memories: ROM, SRAM, DRAM.

Computer organization: Machine instructions and addressing modes, ALU, datapath and control unit, instruction pipe lining.

Control Systems

Basic control system components; Feedback principle; Transfer function; Block diagram representation; Signal flow graph; Transient and steady-state analysis of LTI systems; Frequency response; Routh-Hurwitz and Nyquist stability criteria; Bode and root-locus plots; Lag, lead, and lag-lead compensation; State variable model and solution of state equation of LTI systems.

Communications

Random processes: autocorrelation and power spectral density, properties of white noise, filtering of random signals through LTI systems.

Analog communications: amplitude modulation and demodulation, angle modulation and demodulation, spectra of AM and FM, superheterodyne receivers.

Information theory: entropy, mutual information, and channel capacity theorem. Digital communications: PCM, DPCM, digital modulation schemes (ASK, PSK, FSK, QAM), bandwidth, inter-symbol interference, MAP, ML detection, matched filter receiver, SNR and BER. Fundamentals of error correction, Hamming codes, CRC.

Electric Circuits

Ideal voltage and current sources, dependent sources, R, L, C, M elements; Network solution methods: KCL, KVL, Node and Mesh analysis; Network Theorems: Thevenin's, Norton's, Superposition and Maximum Power Transfer theorem; Transient response of dc and ac networks, sinusoidal steady-state analysis, resonance, two port networks, balanced three phase circuits, star-delta transformation, complex power and power factor in ac circuits.

Bridges and Potentiometers, Measurement of voltage, current, power, energy and power factor; Instrument transformers, Digital voltmeters and multimeters, Phase, Time and Frequency measurement; Oscilloscopes, Error analysis.

Static V-I characteristics and firing/gating circuits for Thyristor, MOSFET, IGBT; DC to DC conversion: Buck, Boost and Buck-Boost Converters; Single and three-phase configuration of uncontrolled rectifiers; Voltage and Current commutated Thyristor based converters; Bidirectional ac to dc voltage source converters; Magnitude and Phase of line current harmonics for uncontrolled and thyristor based converters; Power factor and Distortion Factor of ac to dc converters; Single-phase and three-phase voltage and current source inverters, sinusoidal pulse width modulation.

Electromechanical Systems

Single phase transformer- equivalent circuit, phasor diagram, open circuit and short circuit tests, regulation and efficiency; Three-phase transformers: connections, vector parallel operation; Auto-transformer, groups, Electromechanical energy conversion principles; DC machines: separately excited, series and shunt, motoring and generating mode of operation and their characteristics, speed control of dc motors; Three-phase induction machines: principle of operation, types, performance, torque-speed characteristics, no-load and blocked-rotor tests, equivalent circuit, starting and speed control; Operating principle of single-phase induction motors; Synchronous machines: cylindrical and salient pole machines, performance and characteristics, regulation and parallel operation of generators, starting of synchronous motors; Types of losses and efficiency calculations of electric machines.

Sensors and Instrumentation

Resistive-, capacitive-, inductive-, piezoelectric-, Hall effect sensors and associated signal conditioning circuits; transducers for industrial instrumentation: displacement (linear and angular), velocity, acceleration, force, torque, vibration, shock, pressure (including low pressure), flow (variable head, variable area, electromagnetic, ultrasonic, turbine and open channel flow meters) temperature (thermocouple, bolometer, RTD (3/4 wire), thermistor, pyrometer and semiconductor); liquid level, pH, conductivity and viscosity measurement. 4-20 mAtwo-wire transmitter.